

<b>Notice of References Cited</b>	Application/Control No. 10/620,436	Applicant(s)/Patent Under Reexamination HIGUCHI ET AL.	
	Examiner TAN X. DINH	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,519,064	05-1985	Takagi et al.	369/275.3
*	B	US-6,975,577 b2	12-2005	Kato, Masaki	369/275.4
*	C	US-5,410,534 a	04-1995	Nagata et al.	369/275.4
*	D	US-6,071,588 a	06-2000	Nobumasa et al.	428/64.4
*	E	US-5,838,646 a	11-1998	Watanabe et al.	369/13.53
*	F	US-6,823,528 b2	11-2004	Yamasaki et al.	720/719
*	G	US-6,154,439 a	11-2000	Masuhara et al.	369/275.4
*	H	US-5,559,787 a	09-1996	Nomoto, Takayuki	369/112.02
*	I	US-5,602,824 a	02-1997	Ooki et al.	369/275.4
*	J	US-6,667,952 b2	12-2003	Komaki et al.	369/275.5
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.